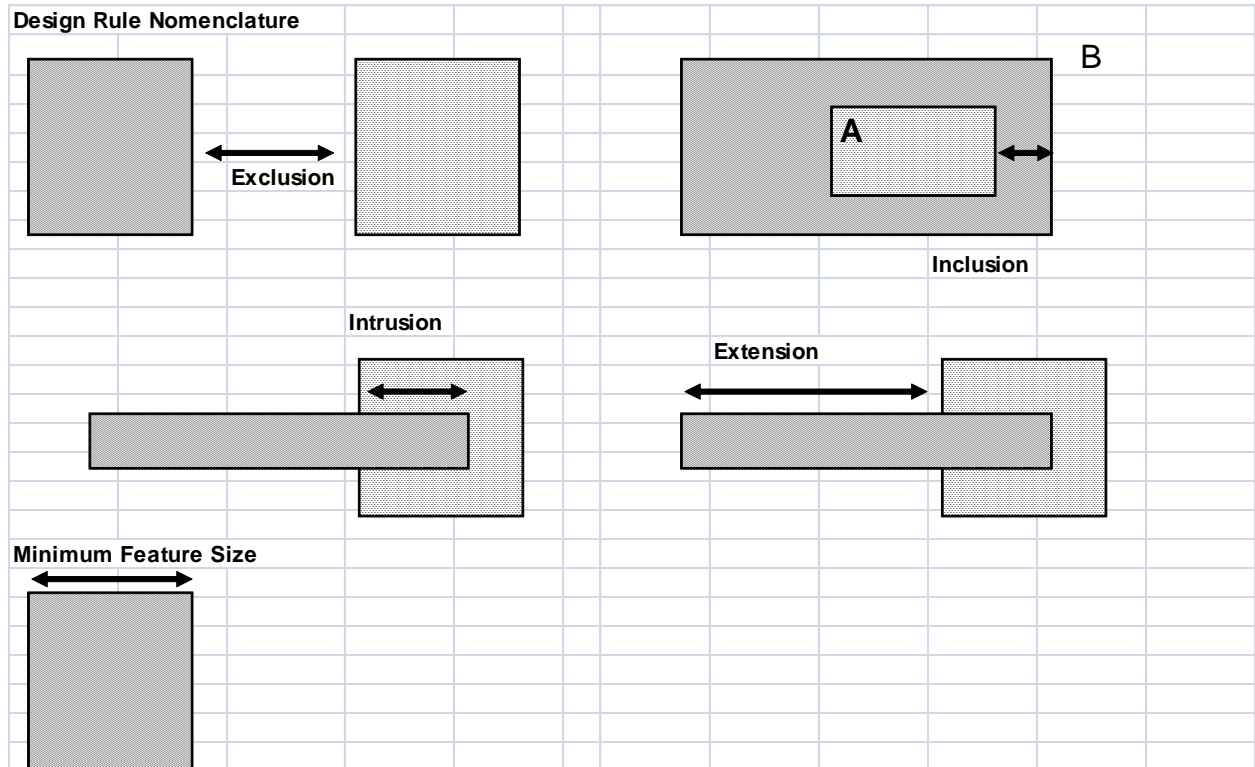


Design Rule Nomenclature



GDS Layer Definition

GDS Layer No.	Description	Field	GDS Grid Resolution (um)	Overlay spec (nm)	Minimum Feature Size (um)	Mask Grade	Fill Density
1	Waveguide - Rib	Dark	0.001	N.A.	0.180	F	20 to 70%
2	Waveguide - Grating Couplers	Dark	0.005	60.000	1.000	A	<30%
3	Waveguide - Slab	Dark	0.005	60.000	0.400	A	<20%
4	PD - Si P+ Implant	Clear	0.005	60.000	1.000	A	0 to 100%
5	MOD+PD - Si P++ implant	Clear	0.005	60.000	1.000	A	0 to 100%
6	MOD - Si N++ implant	Clear	0.005	60.000	1.000	A	0 to 100%
7	MOD - Si P Implant	Clear	0.005	60.000	1.000	A	0 to 100%
8	MOD - Si N Implant	Clear	0.005	60.000	1.000	A	0 to 100%
9	PD - Ge epi	Clear	0.005	60.000	1.000	A	<10%
10	PD - Ge N++ implant	Clear	0.005	60.000	1.000	A	0 to 100%
11	Via 1	Clear	0.005	60.000	1.000	A	<20%
12	Metal 1	Dark	0.005	60.000	1.000	A	20 to 50%
13	Via 2	Clear	0.005	60.000	2.000	A	<20%
14	Metal 2	Dark	0.005	60.000	2.000	A	20 to 50%
15	Bond pad open	Clear	0.005	60.000	2.000	A	<30%
16	Deep Trench	Clear	0.005	60.000	100.000	A	<20%
17	Frontside Oxide Etch	Clear	0.005	60.000	5.000	A	<20%

Minimum Exclusion Rule

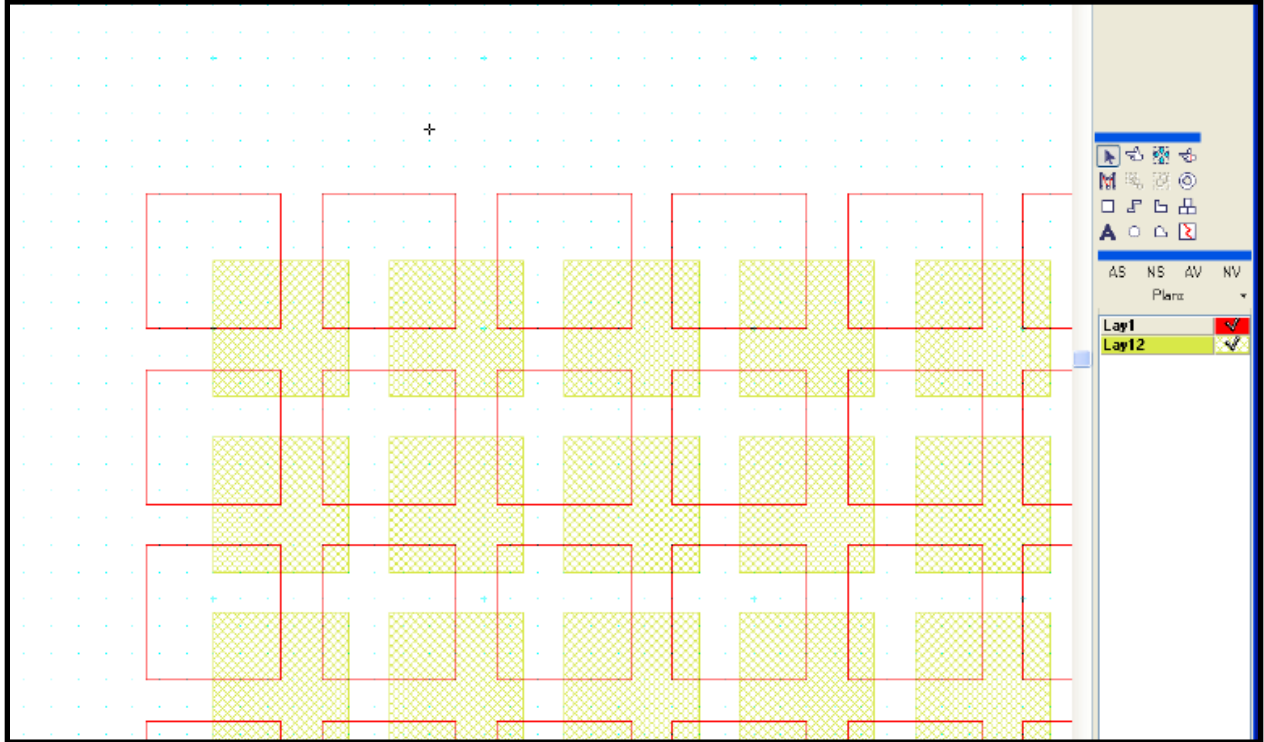
Minimum Exclusion (Minimum separation between A and B) (um)																	
		Waveguide - Rib	Waveguide - Grating Couplers	Waveguide - Slab	PD - Si P+ Implant	MOD+PD - Si P++ implant	MOD - Si N++ implant	MOD - Si P Implant	MOD - Si N Implant	PD - Ge epi	PD - Ge N++ implant	Via 1	Metal 1	Via 2	Metal 2	Bond pad open	Deep Trench
	A \ B	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
Waveguide - Rib	1	0.200															1.000
Waveguide - Grating Couplers	2		0.800														1.000
Waveguide - Slab	3			0.800													1.000
PD - Si P+ Implant	4				0.800												1.000
MOD+PD - Si P++ implant	5					0.800				0.200							1.000
MOD - Si N++ implant	6						0.800			0.200							1.000
MOD - Si P Implant	7							0.800									1.000
MOD - Si N Implant	8								0.800								1.000
PD - Ge epi	9					0.200	0.200			0.800							1.000
PD - Ge N++ implant	10										0.800						1.000
Via 1	11											1.000		2.000			1.000
Metal 1	12												1.000				1.000 5.000
Via 2	13											2.000		2.000			1.000
Metal 2	14														2.000		1.000 5.000
Bond pad open	15															2.000	1.000
Deep Trench	16	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	1.000	2.000 1.000
Frontside Oxide Etch	17												5.000			5.000	1.000 2.000

Mandatory rule: No other GDS layers in deep trench region.

Minimum Inclusion Rule

Minimum Inclusion (B includes A, refer to nomenclature) (um)																		
	B	Waveguide - Rib	Waveguide - Grating Couplers	Waveguide - Slab	PD - Si P+ Implant	MOD+PD - Si P++ implant	MOD - Si N++ implant	MOD - Si P Implant	MOD - Si N Implant	PD - Ge epi	PD - Ge N++ implant	Via 1	Metal 1	Via 2	Metal 2	Bond pad open	Deep Trench	Frontside Oxide Etch
A	A \ B	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17
Waveguide - Rib	1																	
Waveguide - Grating Couplers	2																	
Waveguide - Slab	3																	
PD - Si P+ Implant	4																	
MOD+PD - Si P++ implant	5																	
MOD - Si N++ implant	6																	
MOD - Si P Implant	7																	
MOD - Si N Implant	8																	
PD - Ge epi	9	0.500																
PD - Ge N++ implant	10									1.200								
Via 1	11	0.200		0.200		0.200	0.200				0.200							
Metal 1	12											0.400						
Via 2	13												1.500					
Metal 2	14													1.500				
Bond pad open	15														1.500			
Deep Trench	16																	
Frontside Oxide Etch	17																	

Tiling Rules



- 5 x 5 μm squares with 1.5 μm gap for Waveguide – Rib (Layer 1), and Metal 1 (Layer 12).
Mandatory rule: Only full dummy squares i.e. No truncated squares
- Metal 1 (Layer 12) dummy tiling is translated by 2.5 μm and -2.5 μm in x- and y- direction, respectively, of Waveguide – Rib (Layer 1).
- Tiling must be away from devices/patterns at a minimum distance of 20 μm . No tiling should be present along the nanotaper length.